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PATENT APPLICATION

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of

Toshihiko OGURA, et al.

Group Art Unit: 3736

Application No.: 10/780,569

Filed: February 19, 2004

Docket No.: 118778

For: PULSE WAVE DETECTING APPARATUS

INFORMATION DISCLOSURE STATEMENT

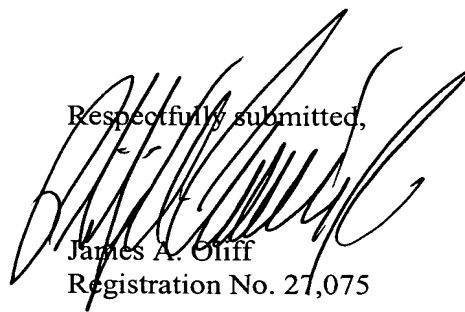
Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Sir:

Pursuant to 37 CFR §1.56, the attention of the Patent and Trademark Office is hereby directed to the reference listed on the attached PTO-1449. Unless otherwise indicated herein, one copy of each reference is attached. It is respectfully requested that the information be expressly considered during the prosecution of this application, and that the reference be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

- ☒ 1. This Information Disclosure Statement is being filed (a) within three months of the U.S. filing date of this non-CPA application, OR (b) before the mailing date of a first Office Action on the merits in the present application. No certification or fee is required.
- ☒ 2. A concise explanation of the relevance of the non-English language reference appears in the Appendix attached hereto.

Respectfully submitted,



James A. Oliff  
Registration No. 27,075

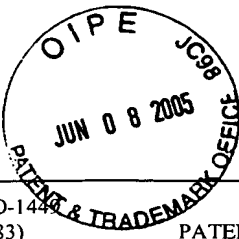
Philip A. Caramanica, Jr.  
Registration No. 51,528

JAO:PAC/vcj

Date: June 8, 2005

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Sheet 1 of 1Form PTO-1449  
(REV. 8-83)US Dept. of Commerce  
PATENT & TRADEMARK OFFICEATTY DOCKET NO.  
118778APPLICATION NO.  
10/780,569

## INFORMATION DISCLOSURE STATEMENT

(Use several sheets if necessary)

APPLICANT(S)  
Toshihiko OGURA et al.FILING DATE  
February 19, 2004GROUP  
3736

## U.S. PATENT DOCUMENTS

| EXAMINER<br>INITIAL |  | DOCUMENT NUMBER | DATE | NAME | CLASS | SUB<br>CLASS |
|---------------------|--|-----------------|------|------|-------|--------------|
|                     |  |                 |      |      |       |              |
|                     |  |                 |      |      |       |              |
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|                     |  |                 |      |      |       |              |
|                     |  |                 |      |      |       |              |

## FOREIGN PATENT DOCUMENTS

|  |   | DOCUMENT NUMBER                         | DATE       | COUNTRY | CLASS | SUB<br>CLASS |
|--|---|---|------------|---------|-------|--------------|
|  | 1 | JP U 63-182712 w/concise<br>explanation | 11/25/1988 | JAPAN   |       |              |
|  |   |   |            |         |       |              |
|  |   |   |            |         |       |              |
|  |   |   |            |         |       |              |

## OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

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EXAMINER

DATE CONSIDERED

Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Date: June 8, 2005